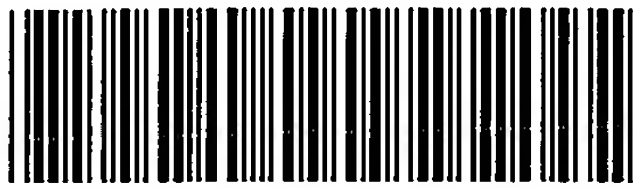


Search Notes



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10/644,772

Examiner

Drew E. Becker

Applicant(s)/Patent under
Reexamination

KOBAYASHI ET AL.

Art Unit

1761

SEARCHED

Class	Subclass	Date	Examiner
search updated		8-4-06	DEB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR